

Search Notes



Application/Control No.

10/644,182

Examiner

José V. Chen

Applicant(s)/Patent under Reexamination

BUECHLER, JAMES G.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
108	180	6/7/05	JLC
	105		
	186		
	187		
	190		
	143		
	153e1		
	155		
	157.18		
	158.12		
312	257e1		
	265e1		
	265e2		
	195		
250	180		
	188e1	11/16/05	JLC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Front & back. Citations for Prior Art	6/7/05	JLC
ADACOR	11/16/05	JLC